Probe Form® will provide a cost-effective method of uniformly "shaping" and "forming probe tips.

Probe Polish® will collect loose debris that was generated during probing. Probe Polish® abrasiveness will remove accumulation of embedded or bonded debris while maintaining the probe contact area.

Probe Clean® is designed to remove loose debris, which is generated during probing. It is not effective for removing embedded or bonded debris.

PC – Debris Collection  PP – Online Cleaning  PF – Offline Forming